

Search Notes

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Examiner

Sy D. Luu

Applicant(s)/Patent under
Reexamination

SEKIGUCHI ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
715	781,792, 806,807	5/29/2007	SL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT US-PGPUB EPO JPO DERWENT	5/29/2007	SL
Text Searches: 715/781,790-797,803,804,806,807	5/29/2007	SL